

Notice of References Cited	Application/Control No. 10/015,564	Applicant(s)/Patent Under Reexamination KUTSUNA ET AL.	
	Examiner Christopher M. Keehan	Art Unit 1712	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,356,961	10-1994	Nishimura et al.	523/414
	B	US-3,683,044	08-1972	Ching Yun Huang; et. al.	525/526
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Abstract, JP 61012723, Horie et al., January 21, 1986.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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